Notice of References Cited Application/Control No. 10/567,869 Examiner SUSAN E. FERNANDEZ Applicant(s)/Patent Under Reexamination GOODMAN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2001/0044156	11-2001	Kelly et al.	436/174
*	В	US-5,994,498	11-1999	Tripathy et al.	528/422
*	С	US-5,552,216	09-1996	Sugimoto et al.	428/328
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

	NON TALLA BOOGNERIU							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U	Ban, LL et al. Determining the polymer domain structure of TPE blends by microscopy techniques. Rubber World. 1993. 207(4): 20-22.						
	٧							
	w							
	х							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.